

**Search Notes**

Application/Control No.

10/658,839

Examiner

Y. Lee

Applicant(s)/Patent under  
Reexamination

YU ET AL.

Art Unit

2621

**SEARCHED**

Class	Subclass	Date	Examiner
375	240.01 240.16 240.24 240.26	7/16/2007	YL
348	208.99		
H04N	7/12		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR